

# NOVASTACK® 35-P HIGH CONDUCTIVITY TYPE

Part No. PLUG: 20708-0\*\*E-01 Receptacle: 20709-0\*\*E-01

## Test Report

Product Specification no. PRS-2334

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7	T19008	January 29, 2019	T.Kurokawa	Y.Baba	T.Hirakawa
6	T17185	December 7, 2017	M.Hirotani	Y.Baba	T.Hirakawa
5	T17169	October 26, 2017	M.Hirotani	Y.Baba	T.Hirakawa
Rev.	ECN	Date	Prepared by	Checked by	Approved by

## 1. 目的

NOVASTACK 35-P(高電導タイプ)コネクタの性能を PRS-2334 に基づいて評価する。

## 2. 資料

- (1) NOVASTACK 35-P PLUG ASS'Y (Part No. 20708-0\*\*E-01)
- (2) NOVASTACK 35-P RECEPTACLE ASS'Y (Part No. 20709-0\*\*E-01)

## 3. 試験順序

全ての評価は表 1 の試験順序に従って行った。

## 4. 結果

表 2-1~2-4、グラフ 1~38 参照。試験条件の詳細は PRS-2334 参照。  
n 数は測定データを意味する。

## 5. 結論

全ての資料が製品規格(PRS-2334)の必要条件を満足した。

Table 1 試験順序と試料数

試験項目	グループ													
	A	B	C	D	E	F	G	H	J	K	L	M	N	P
接触抵抗		2,6		1,3,5	1,5	1,3	1,3	1,5	1,5	1,3	1,3			
絶縁抵抗					2,6			2,6	2,6					
耐電圧					3,7			3,7	3,7					
温度上昇	1													
挿入力		1,5												
抜去力		3,7												
耐久性		4												
端子保持力			1											
耐振動性				2										
耐衝撃性				4										
熱衝撃					4									
高温寿命						2								
低温寿命							2							
湿度（定常状態）								4						
湿度（サイクリング）									4					
塩水噴霧										2				
硫化水素ガス											2			
半田付け性												1		
半田耐熱性													1	
手半田														1
試料数	5 pcs.	5 pcs.	20 pcs.	5 pcs.	5 pcs.	5 pcs.	5 pcs.	5 pcs.	5 pcs.	5 pcs.	5 pcs.	10 pcs.	10 pcs.	10 pcs.

※グループ表中の番号は、試験順序を示す。

Table 2-1. 試験結果

Contents of measurement	Spec.	Unit	Q'ty	n	Data					Judge.	
					AVE.	MAX.	MIN.	S	X±3s		
Temperature rising											
10P	test (a)	ΔT 30 MAX.	℃	5	-	14.9 Max.					OK
	test (b)					23.8 Max.					OK
14P	test (a)	ΔT 30 MAX.	℃	5	-	17.1 Max.					OK
	test (b)					20.1 Max.					OK
18P	test (a)	ΔT 30 MAX.	℃	5	-	15.7 Max.					OK
	test (b)					15.4 Max.					OK
20P	test (a)	ΔT 30 MAX.	℃	5	-	18.2 Max.					OK
	test (b)					18.6 Max.					OK
24P	test (a)	ΔT 30 MAX.	℃	5	-	15.9 Max.					OK
	test (b)					15.8 Max.					OK
30P	test (a)	ΔT 30 MAX.	℃	5	-	14.5 Max.					OK
	test (b)					19.8 Max.					OK
34P	test (a)	ΔT 30 MAX.	℃	5	-	15.4 Max.					OK
	test (b)					20.3 Max.					OK
40P	test (a)	ΔT 30 MAX.	℃	5	-	15.6 Max.					OK
	test (b)					21.8 Max.					OK
50P	test (a)	ΔT 30 MAX.	℃	5	-	10.0 Max.					OK
	test (b)					19.0 Max.					OK
60P	test (a)	ΔT 30 MAX.	℃	5	-	14.3 Max.					OK
	test (b)					20.5 Max.					OK

Table 2-2. 試験結果

Group	Contents of measurement	Spec.	Unit	Q'ty	n	Data					Judge.		
						AVE.	MAX.	MIN.	S	X±3s			
B	Durability												
	Contact resistance												
	Signal contact	Initial	30	MAX.	mΩ	5	100	15.768	18.78	13.24	1.341	19.792	OK
		After 20 cycles	ΔR 20	MAX.				-2.067	-0.03	-4.46	1.164	1.423	OK
	Power contact	Initial	30	MAX.			20	10.925	12.98	10.13	0.868	13.529	OK
		After 20 cycles	ΔR 20	MAX.				-0.305	1.08	-2.61	0.922	2.460	OK
	Mating force												
	10P	Initial	20	MAX.	N	5	-	10.660	10.86	10.42	-	-	OK
		After 20 cycles						7.027	7.70	6.38	-	-	OK
	14P	Initial	28	MAX.	N	5	-	14.958	15.53	14.04	-	-	OK
		After 20 cycles						7.444	8.07	6.87	-	-	OK
	18P	Initial	36	MAX.	N	5	-	16.996	17.66	16.29	-	-	OK
		After 20 cycles						10.373	10.67	10.10	-	-	OK
	20P	Initial	40	MAX.	N	5	-	18.220	18.95	17.60	-	-	OK
		After 20 cycles						11.057	11.93	10.10	-	-	OK
	24P	Initial	48	MAX.	N	5	-	19.950	20.96	18.72	-	-	OK
		After 20 cycles						12.960	13.53	12.23	-	-	OK
	30P	Initial	30	MAX.	N	5	-	15.150	15.70	14.49	-	-	OK
		After 20 cycles						13.641	14.25	12.86	-	-	OK
	34P	Initial	34	MAX.	N	5	-	13.986	14.69	13.71	-	-	OK
		After 20 cycles						11.438	12.12	11.07	-	-	OK
	40P	Initial	40	MAX.	N	5	-	20.604	21.71	11.07	-	-	OK
		After 20 cycles						14.898	16.03	13.99	-	-	OK
	50P	Initial	50	MAX.	N	5	-	26.059	26.83	25.08	-	-	OK
		After 20 cycles						19.499	20.08	18.72	-	-	OK
	60P	Initial	60	MAX.	N	5	-	26.560	28.13	24.46	-	-	OK
		After 20 cycles						17.373	19.70	15.81	-	-	OK
	Unmating force												
	10P	Initial	3.0	MIN.	N	5	-	7.880	8.24	7.66	-	-	OK
		After 20 cycles						6.392	6.57	6.29	-	-	OK
	14P	Initial	4.2	MIN.	N	5	-	7.413	7.82	6.92	-	-	OK
		After 20 cycles						5.849	6.04	5.60	-	-	OK
	18P	Initial	5.4	MIN.	N	5	-	11.182	11.56	10.82	-	-	OK
		After 20 cycles						9.084	9.37	8.86	-	-	OK
	20P	Initial	6.0	MIN.	N	5	-	11.947	12.63	10.49	-	-	OK
		After 20 cycles						9.660	10.29	9.28	-	-	OK
	24P	Initial	7.2	MIN.	N	5	-	15.119	15.68	14.41	-	-	OK
		After 20 cycles						12.665	13.35	12.19	-	-	OK
	30P	Initial	4.5	MIN.	N	5	-	11.585	12.01	10.93	-	-	OK
		After 20 cycles						11.861	12.51	11.03	-	-	OK
	34P	Initial	5.1	MIN.	N	5	-	11.466	12.10	10.17	-	-	OK
		After 20 cycles						11.272	11.86	10.05	-	-	OK
	40P	Initial	6.0	MIN.	N	5	-	15.016	15.59	14.52	-	-	OK
		After 20 cycles						13.646	14.63	12.88	-	-	OK
	50P	Initial	7.5	MIN.	N	5	-	18.290	18.78	17.53	-	-	OK
		After 20 cycles						18.290	19.27	16.98	-	-	OK
	60P	Initial	9.0	MIN.	N	5	-	21.702	23.86	19.68	-	-	OK
After 20 cycles		19.100						20.94	17.58	-	-	OK	

Table 2-3. 試験結果

Group	Contents of measurement	Spec.	Unit	Q'ty	n	Data					Judge.			
						AVE.	MAX.	MIN.	S	X±3s				
C	Contact retention force													
	Receptacle contact	0.1 MIN.	N	20	-	0.531	0.62	0.41	-	-	OK			
D	Vibration → Shock													
	Contact resistance													
	Signal contact	Initial	30 MAX.	mΩ	5	100	15.228	16.81	13.88	0.663	17.217	OK		
		After vibration	ΔR 20 MAX.				0.325	3.11	-2.67	1.258	4.100	OK		
		After shock					0.376	3.36	-2.77	1.147	3.816	OK		
	Power contact	Initial	30 MAX.				20	11.643	12.32	10.98	0.385	12.798	OK	
		After vibration	ΔR 20 MAX.					1.606	3.94	-0.85	1.351	5.658	OK	
		After shock						0.977	4.03	-1.87	1.635	5.882	OK	
	Electrical discontinuity													
		During test	1 MAX.	μs	5	-		No discontinuity					OK	
	Appearance													
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK			
E	Contact resistance													
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.353	18.40	14.77	0.824	18.825	OK		
		After test	ΔR 20 MAX.				0.096	1.91	-1.72	0.685	2.151	OK		
	Power contact	Initial	30 MAX.				20	11.558	12.55	10.87	0.528	13.143	OK	
		After test	ΔR 20 MAX.					0.183	1.08	-0.42	0.477	1.612	OK	
	Insulation resistance													
		Initial	1000 MIN.			MΩ	5	-	1.34 × 10 <sup>4</sup> Min.					OK
		After test	500 MIN.	2.24 × 10 <sup>4</sup> Min.					OK					
	Dielectric Withstanding Voltage													
		After test	No abnormalities such as creeping discharge, flashover, insulator breakdown occur.	-	5	-	No abnormality					OK		
	Appearance													
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK			
F	High temperature life													
	Contact resistance													
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.510	18.92	14.54	0.835	19.014	OK		
		After test	ΔR 20 MAX.				-0.306	1.34	-2.14	0.736	1.901	OK		
	Power contact	Initial	30 MAX.				20	12.035	13.95	10.99	1.000	15.033	OK	
		After test	ΔR 20 MAX.					-1.235	-0.35	-2.85	0.726	0.943	OK	
	Appearance													
	After test	No abnormality adversely affecting the performance shall occur.	-			5	-	No abnormality					OK	
G	Low temperature life													
	Contact resistance													
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.413	17.58	14.90	0.634	18.314	OK		
		After test	ΔR 20 MAX.				-0.795	0.48	-2.07	0.493	0.682	OK		
	Power contact	Initial	30 MAX.				20	12.014	12.44	11.63	0.281	12.856	OK	
		After test	ΔR 20 MAX.					-0.455	0.73	-1.16	0.622	1.412	OK	
	Appearance													
		After test	No abnormality adversely affecting the performance shall occur.			-	5	-	No abnormality					OK

Table 2-4. 試験結果

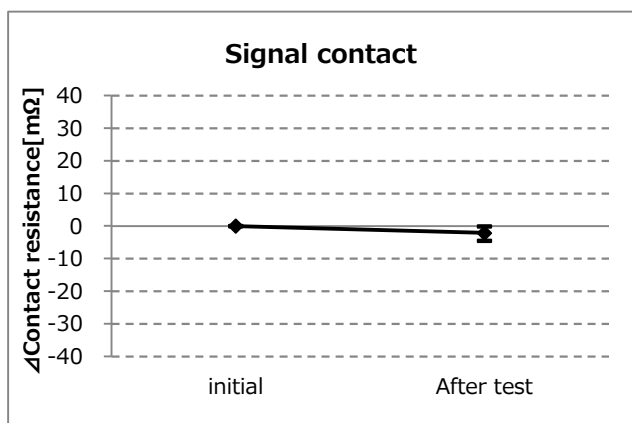
Group	Contents of measurement	Spec.	Unit	Q'ty	n	Data					Judge.	
						AVE.	MAX.	MIN.	S	X±3s		
H	Humidity(steady state)											
	Contact resistance											
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.431	17.92	14.80	0.678	18.463	OK
		After test	ΔR 20 MAX.				-0.176	1.15	-1.82	0.585	1.580	OK
	Power contact	Initial	30 MAX.			20	12.041	12.93	11.33	0.456	13.408	OK
		After test	ΔR 20 MAX.				0.020	1.16	-0.96	0.672	2.036	OK
	Insulation resistance											
		After test	500 MIN.	MΩ	5	-	2.99 x 10 <sup>3</sup> Min.					OK
	Dielectric Withstanding Voltage											
		After test	No abnormalities such as creeping discharge, flashover, insulator breakdown occur.	-	5	-	No abnormality					OK
Appearance												
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	
J	Humidity(cycling)											
	Contact resistance											
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.250	18.90	13.99	1.189	19.818	OK
		After test	ΔR 20 MAX.				-0.188	2.30	-2.36	0.992	2.788	OK
	Power contact	Initial	30 MAX.			20	11.730	13.16	10.33	0.940	14.550	OK
		After test	ΔR 20 MAX.				-0.289	1.09	-1.44	0.734	1.913	OK
	Insulation resistance											
		Initial	1000 MIN.	MΩ	5	-	1.12 x 10 <sup>4</sup> Min.					OK
		After test	500 MIN.				2.46 x 10 <sup>3</sup> Min.					OK
	Dielectric Withstanding Voltage											
	After test	No abnormalities such as creeping discharge, flashover, insulator breakdown occur.	-	5	-	No abnormality					OK	
Appearance												
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	
K	Salt water spray											
	Contact resistance											
	Signal contact	Initial	30 MAX.	mΩ	5	100	15.805	18.83	14.07	1.098	19.099	OK
		After test	ΔR 20 MAX.				-0.600	3.63	-3.91	1.684	4.451	OK
	Power contact	Initial	30 MAX.			20	12.211	13.90	10.58	1.056	15.378	OK
		After test	ΔR 20 MAX.				-0.503	3.43	-3.74	1.759	4.774	OK
	Appearance											
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	

Table 2-5 試験結果

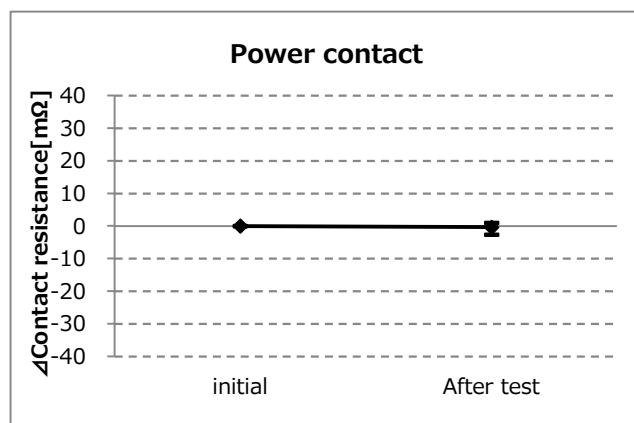
Group	Contents of measurement	Spec.	Unit	Q'ty	n	Data					Judge.	
						AVE.	MAX.	MIN.	S	X±3s		
L	Gas											
	Contact resistance											
	Signal contact	Initial	30 MAX.	mΩ	5	100	16.278	17.98	15.17	0.646	18.215	OK
		After test	ΔR 20 MAX.				1.121	3.93	-0.95	1.111	4.453	OK
	Power contact	Initial	30 MAX.			20	12.674	14.13	11.47	0.972	15.590	OK
		After test	ΔR 20 MAX.				0.917	2.52	-0.01	0.911	3.652	OK
Appearance												
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	
M	Solder ability											
	Solder wetting area											
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	
N	Resistance to reflow soldering heat											
	Appearance											
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	
P	Soldering iron											
	Appearance											
	After test	No abnormality adversely affecting the performance shall occur.	-	5	-	No abnormality					OK	



**B Group / Durability**

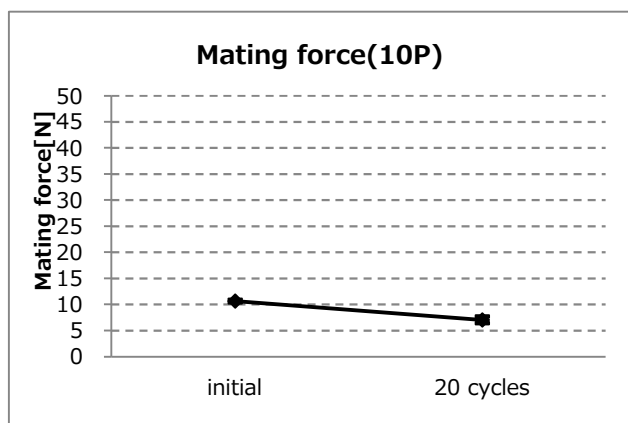


Graph-1. A change of signal contact resistance

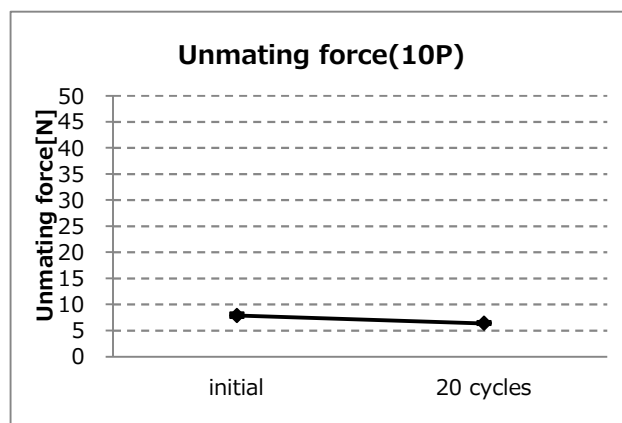


Graph-2. A change of power contact resistance

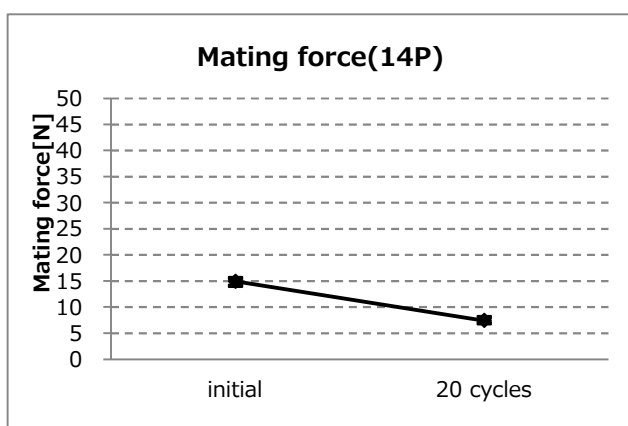
**B Group / Durability**



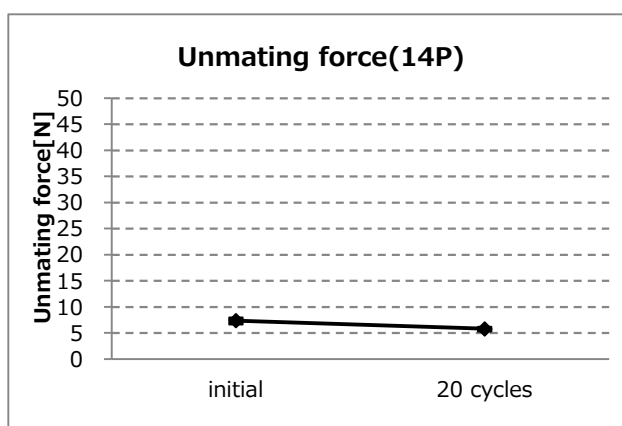
Graph-3. A change of mating force (10P)



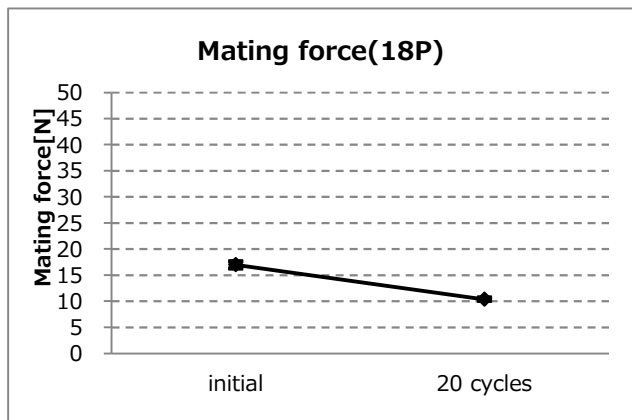
Graph-4. A change of unmating force (10P)



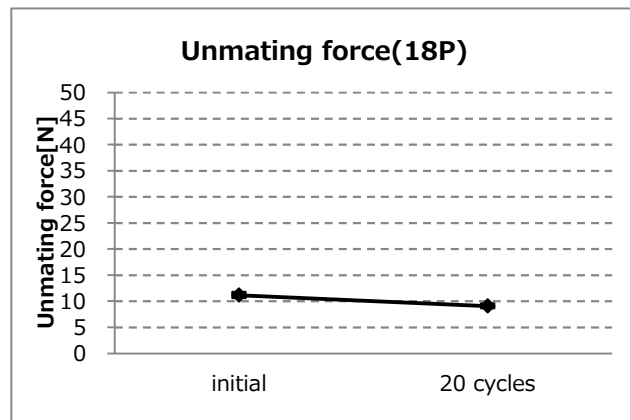
Graph-5. A change of mating force (14P)



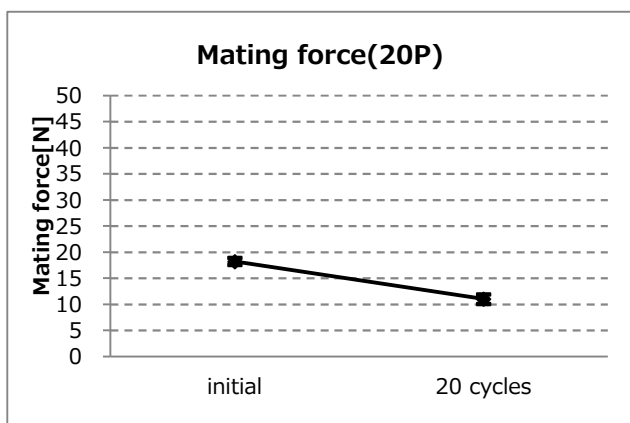
Graph-6. A change of unmating force (14P)



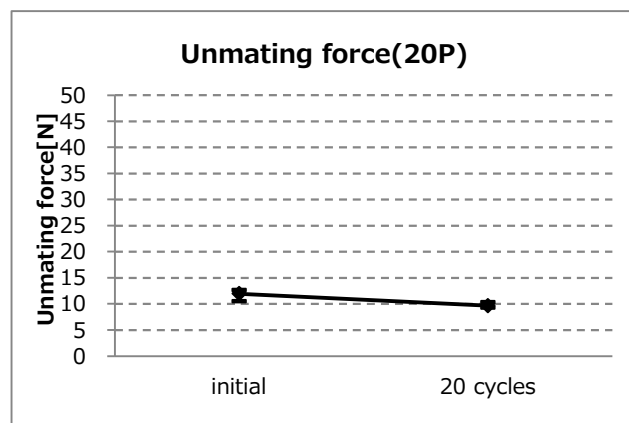
Graph-7. A change of mating force (18P)



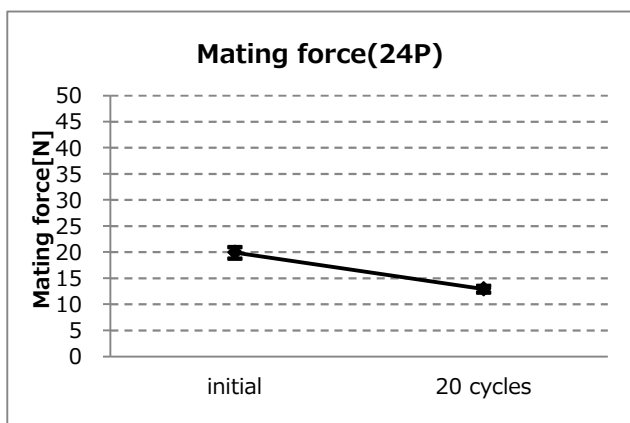
Graph-8. A change of unmating force (18P)



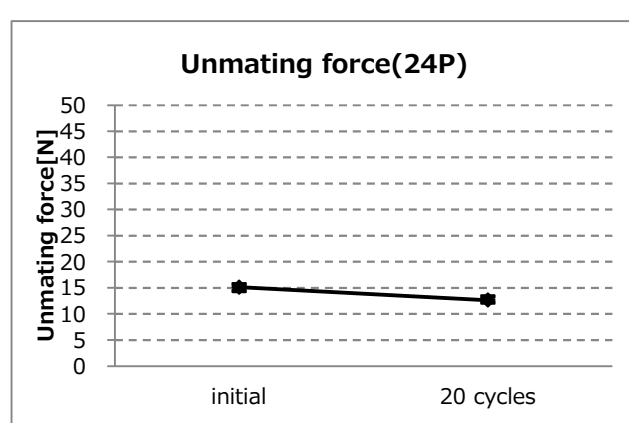
Graph-9. A change of mating force (20P)



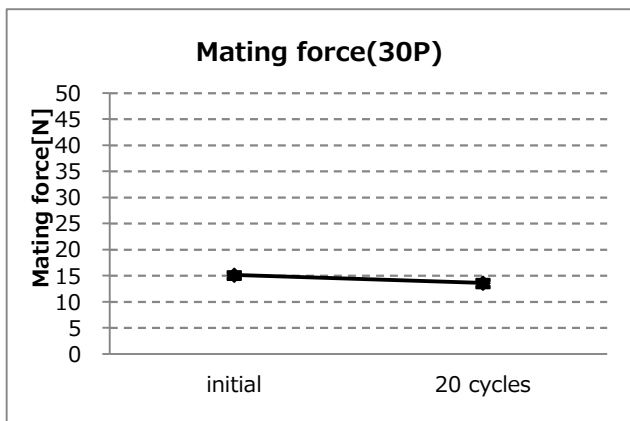
Graph-10. A change of unmating force (20P)



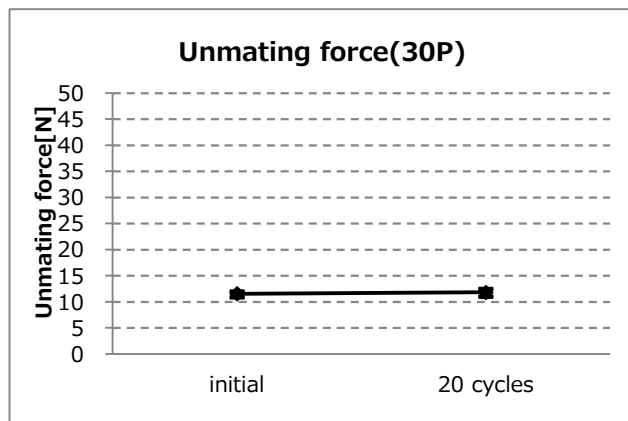
Graph-11. A change of mating force (24P)



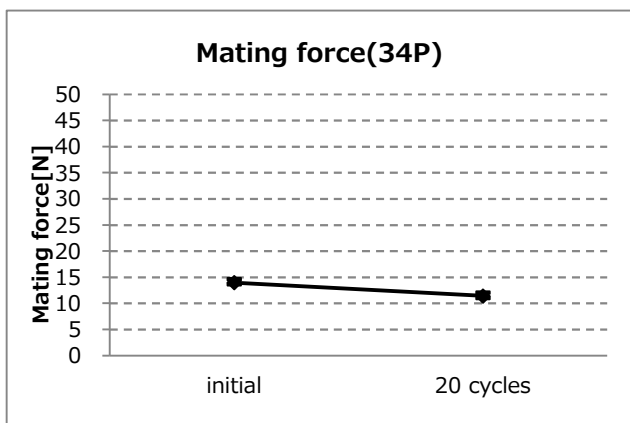
Graph-12. A change of unmating force (24P)



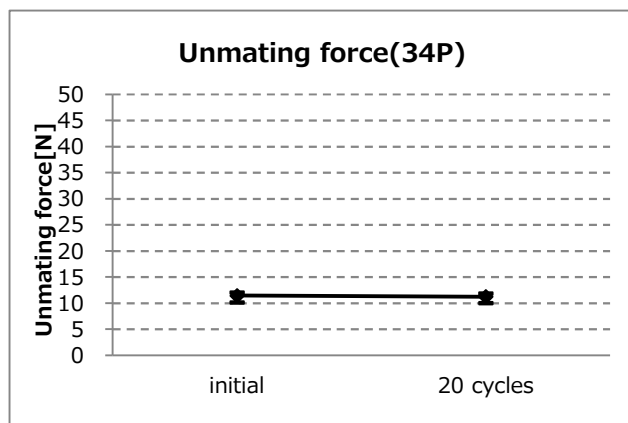
Graph-13. A change of mating force (30P)



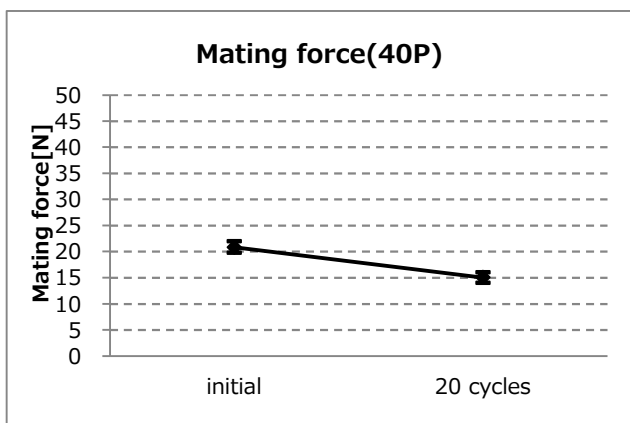
Graph-14. A change of unmating force (30P)



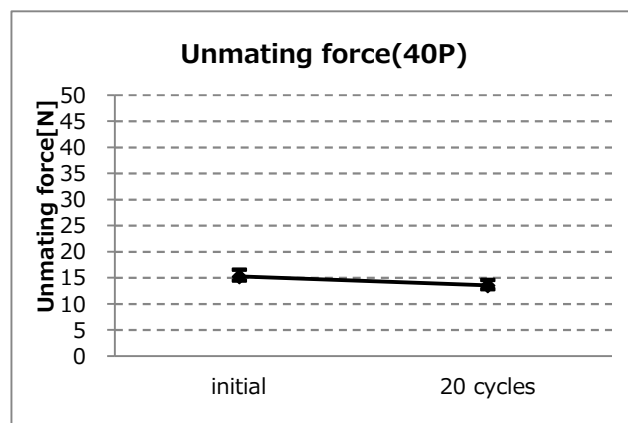
Graph-15. A change of mating force (34P)



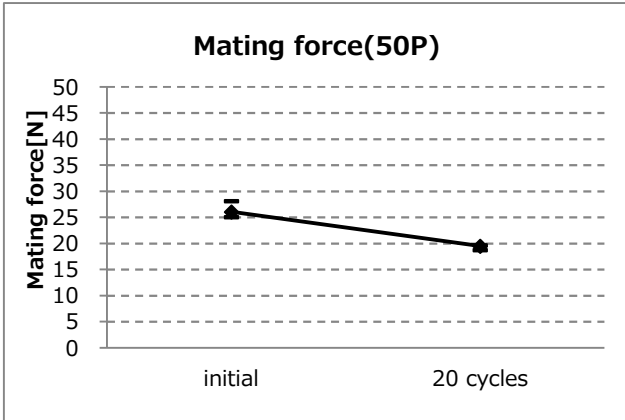
Graph-16. A change of unmating force (34P)



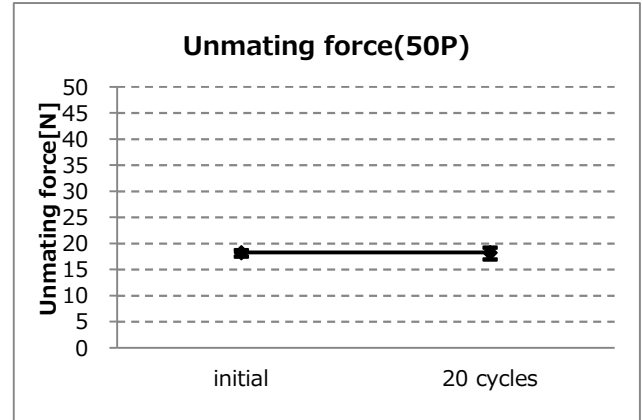
Graph-17. A change of mating force (40P)



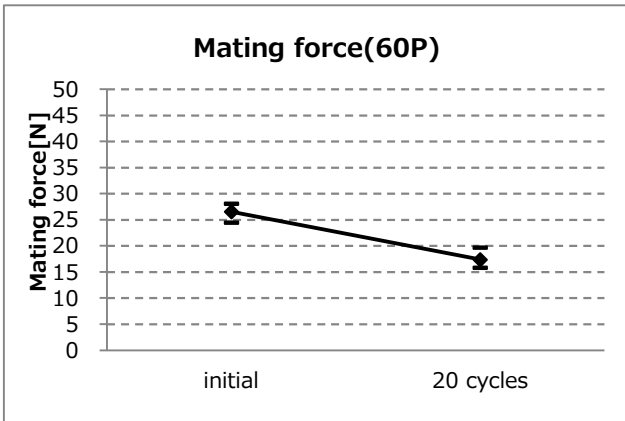
Graph-18. A change of unmating force (40P)



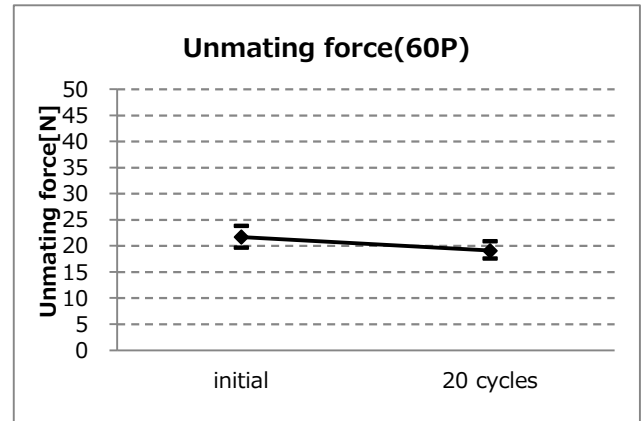
Graph-19. A change of mating force (50P)



Graph-20. A change of unmatting force (50P)

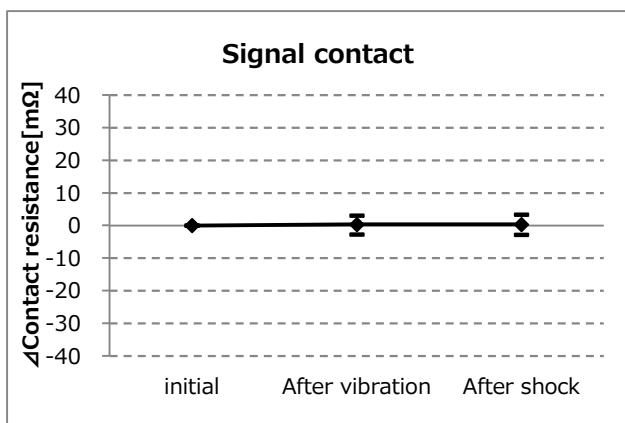


Graph-21. A change of mating force (60P)

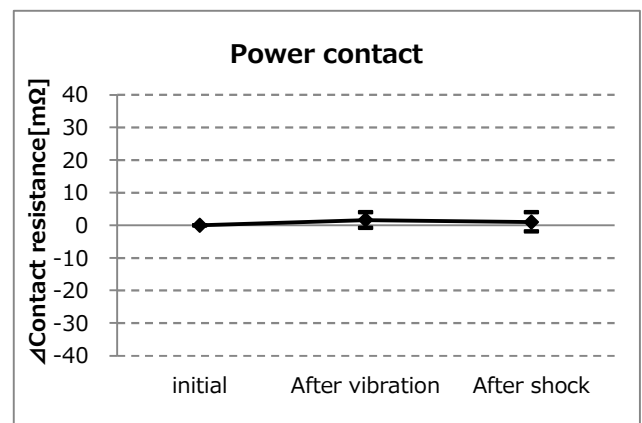


Graph-22. A change of unmatting force (60P)

D Group / Vibration → Shock

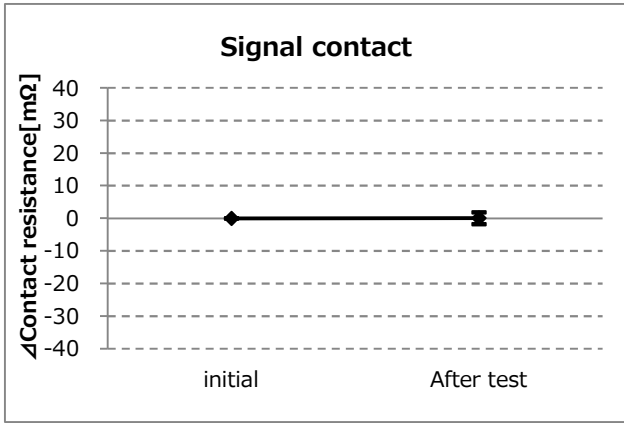


Graph-23. A change of signal contact resistance

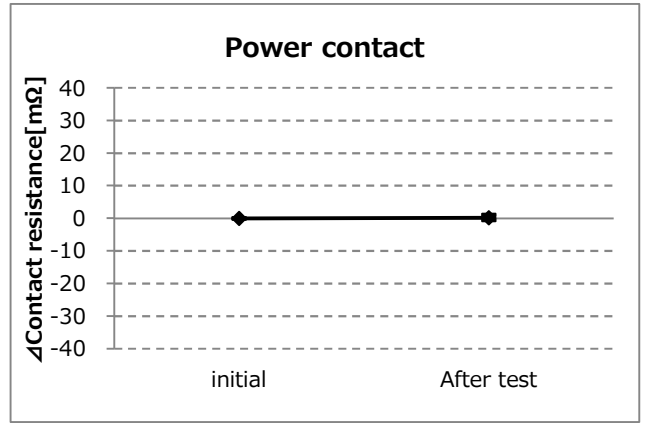


Graph-24. A change of power contact resistance

**E Group / Thermal Shock**

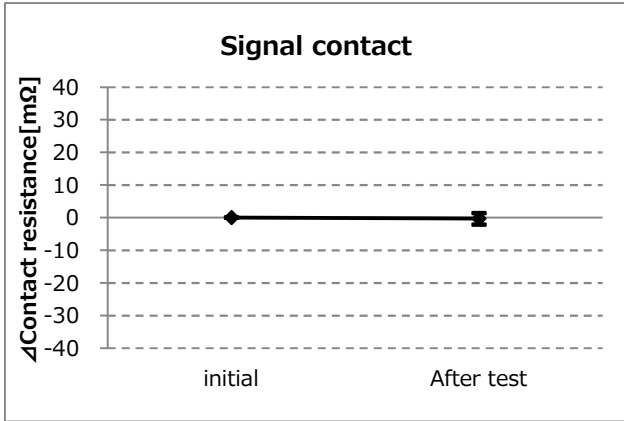


Graph-25. A change of signal contact resistance

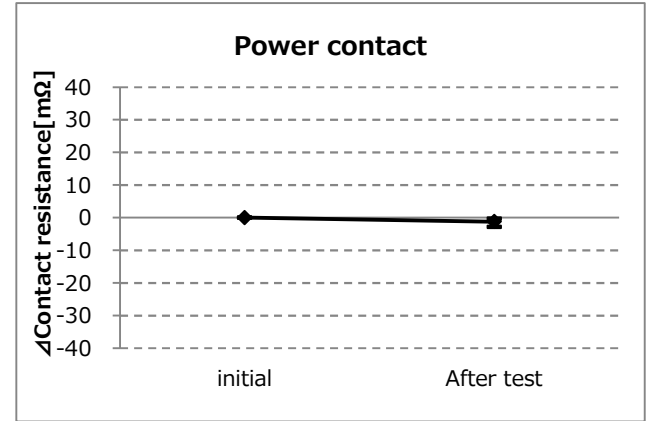


Graph-26. A change of power contact resistance

**F Group / High Temperature Life**

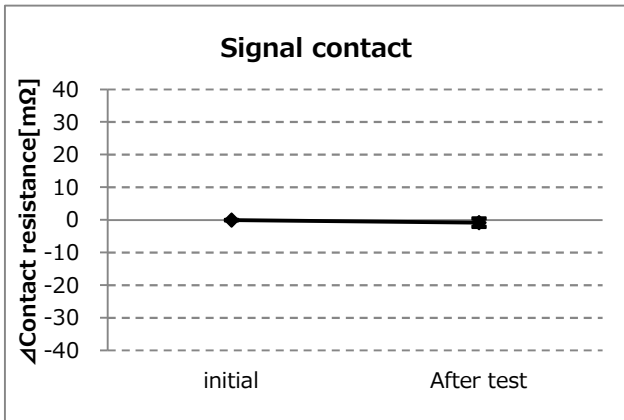


Graph-27. A change of signal contact resistance

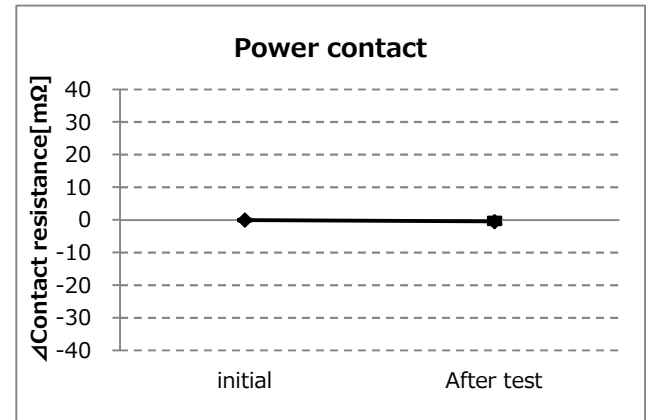


Graph-28. A change of power contact resistance

**G Group / Low Temperature Life**

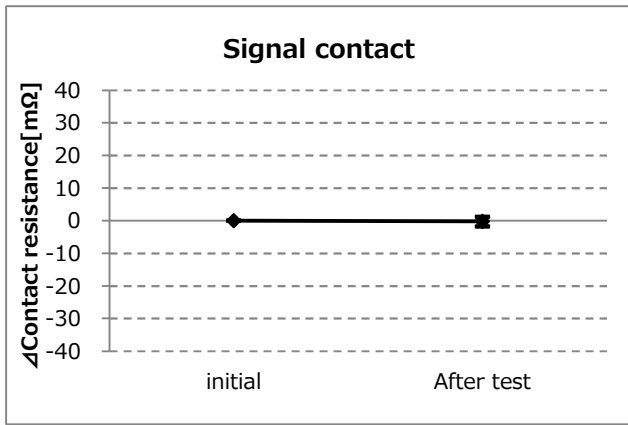


Graph-29. A change of signal contact resistance

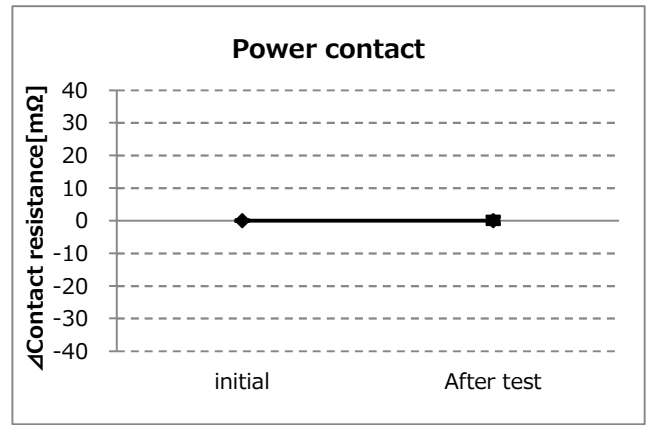


Graph-30. A change of power contact resistance

H Group / Humidity (Steady State)

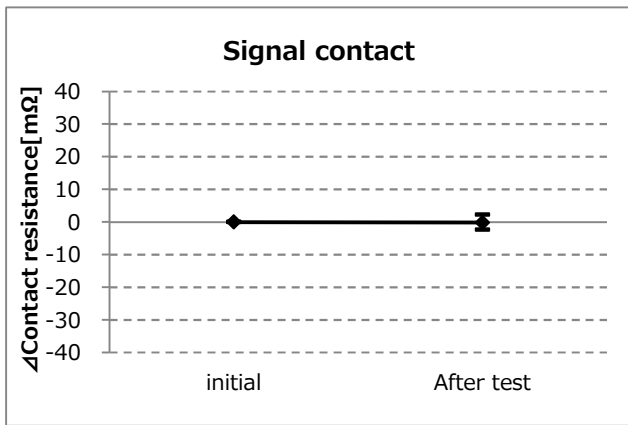


Graph-31. A change of signal contact resistance

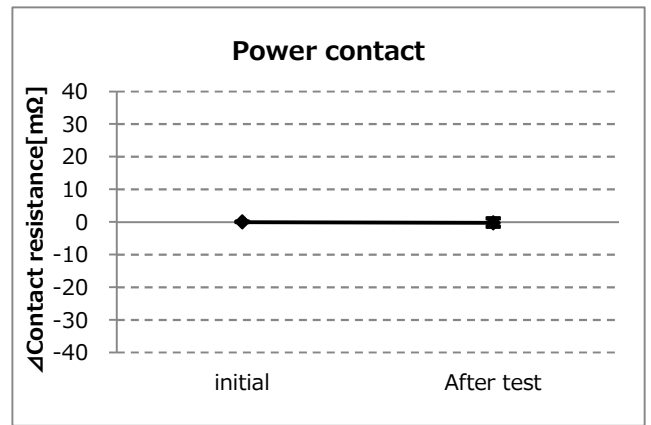


Graph-32. A change of power contact resistance

J Group / Humidity (Cycling)

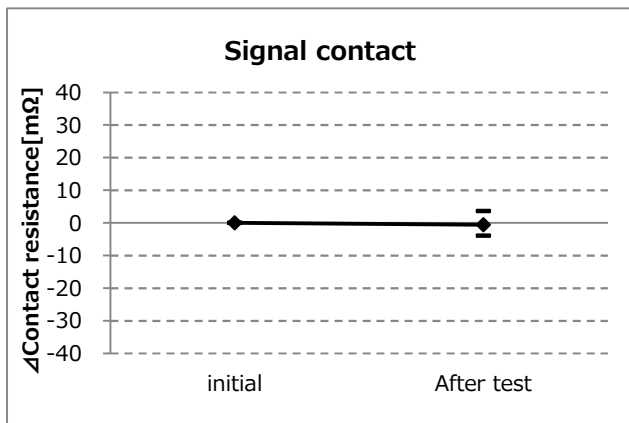


Graph-33. A change of signal contact resistance

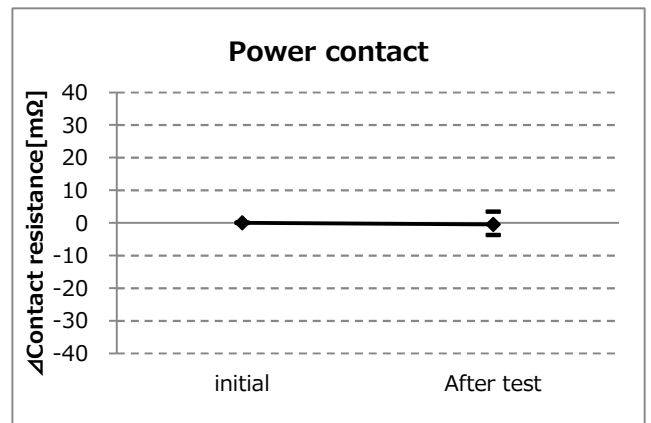


Graph-34. A change of power contact resistance

K Group / Salt Water Spray

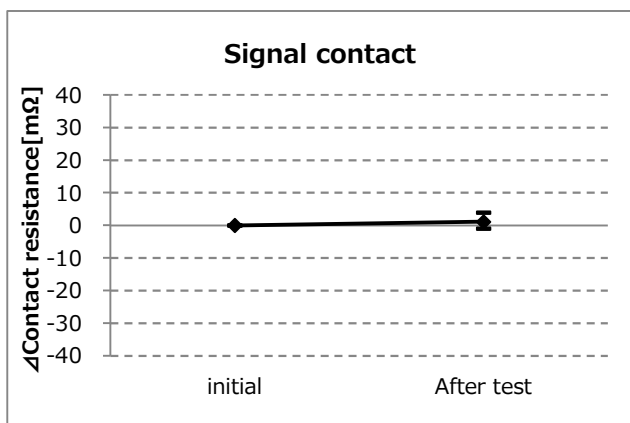


Graph-35. A change of signal contact resistance

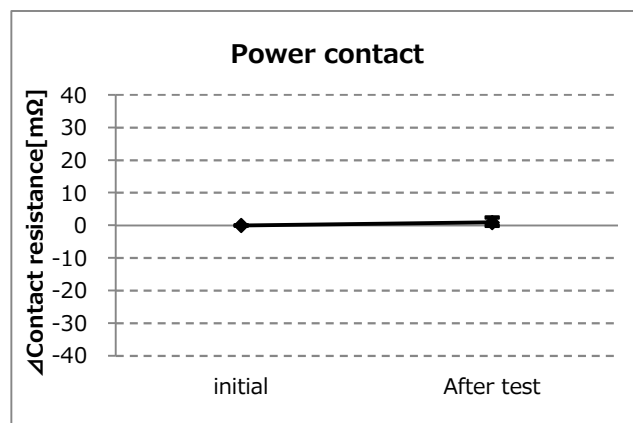


Graph-36. A change of power contact resistance

L Group / H2S Gas



Graph-37. A change of signal contact resistance



Graph-38. A change of power contact resistance